	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/735,446	YOON ET AL.
	Examiner	Art Unit	
	Jared W. Newton	3692	

ISSUE CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)						
CLASS	**SUBCLASS**	**CLASS**	**SUBCLASS (ONE SUBCLASS PER BLOCK)**					
211	26	211	4	183				
INTERNATIONAL CLASSIFICATION		16	221	326				
F 1 6 C	11/04	248	218.4	221.11				
A 4 7 F	7/00	292	60					
	/							
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Jared W. Newton 12/31/2007 (Assistant Examiner) (Date)		**Total Claims Allowed: 20**	
(Legal Instruments Examiner) (Date) 4/14/08	*Jans Hum* 1.2.08 JAMES A. KRAMER SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3600	O.G. Print Claim(s) 1	O.G. Print Fig. 6

☐ Claims renumbered in the same order as presented by applicant		☐ CPA	☐ T.D.	☐ R.1.47

Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
1	1		31		61		91		121		151		181
2	2		32		62		92		122		152		182
3	3	17	33		63		93		123		153		183
4	4		34		64		94		124		154		184
5	5		35		65		95		125		155		185
6	6		36		66		96		126		156		186
	7		37		67		97		127		157		187
	8		38		68		98		128		158		188
7	9		39		69		99		129		159		189
	10		40		70		100		130		160		190
	11		41		71		101		131		161		191
	12		42		72		102		132		162		192
	13		43		73		103		133		163		193
	14		44		74		104		134		164		194
	15		45		75		105		135		165		195
	16		46		76		106		136		166		196
	17		47		77		107		137		167		197
8	18		48		78		108		138		168		198
9	19		49		79		109		139		169		199
10	20		50		80		110		140		170		200
11	21		51		81		111		141		171		201
12	22		52		82		112		142		172		202
13	23		53		83		113		143		173		203
14	24		54		84		114		144		174		204
15	25		55		85		115		145		175		205
16	26		56		86		116		146		176		206
18	27		57		87		117		147		177		207
19	28		58		88		118		148		178		208
20	29		59		89		119		149		179		209
	30		60		90		120		150		180		210